

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/717,549	SAINT ETIENNE ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Albert T. Chou	2616	

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,188,689	02-2001	Katsube et al.	370/389
B	US-6,282,669	08-2001	Imanaka et al.	714/4
C	US-6,721,273	04-2004	Lyon, Norman A.	370/235
D	US-2002/0090946 A1	07-2002	Mielke et al.	455/435
E	US-6,615,271	09-2003	Lauck et al.	709/232
F	US-6,766,482	07-2004	Yip et al.	714/717
G	US-2006/0107108 A1	05-2006	Geng et al.	714/011
H	US-5,379,278	01-1995	Safadi, Reem B.	370/221
I	US-4,780,869	10-1988	Engdahl et al.	370/228
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
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Q					
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T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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